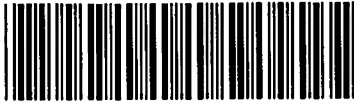


Search Notes

Application/Control No.

10/666,024

Examiner

Phung My Chung

Applicant(s)/Patent under
Reexamination

HAYHOW, REID

Art Unit

2117

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST searched 714/718, 738, 721, 733, 734, 30, 725, 726; 365/200, 201. See print out.	1/10/2008	PMC